# Low-Voltage CMOS Quad 2-Input AND Gate

# With 5 V-Tolerant Inputs

The 74LVC08A is a high performance, quad 2–input AND gate operating from a 1.2 to 3.6 V supply. High impedance TTL compatible inputs significantly reduce current loading to input drivers while TTL compatible outputs offer improved switching noise performance. A  $V_{\rm I}$  specification of 5.5 V allows 74LVC08A inputs to be safely driven from 5.0 V devices.

Current drive capability is 24 mA at the outputs.

#### **Features**

- Designed for 1.2 V to 3.6 V V<sub>CC</sub> Operation
- 5.0 V Tolerant Inputs Interface Capability With 5.0 V TTL Logic
- 24 mA Output Sink and Source Capability
- Near Zero Static Supply Current (10 μA) Substantially Reduces System Power Requirements
- ESD Performance: Human Body Model >2000 V Machine Model >200 V
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant



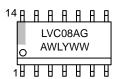
#### ON Semiconductor®

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#### MARKING DIAGRAMS



SOIC-14 D SUFFIX CASE 751A





TSSOP-14 DT SUFFIX CASE 948G



A = Assembly Location

L, WL = Wafer Lot
Y = Year
W, WW = Work Week
G or = Pb-Free Package

(Note: Microdot may be in either location)

#### ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

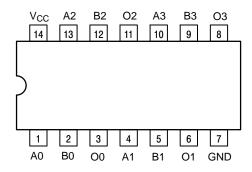


Figure 1. Pinout: 14-Lead (Top View)

#### Α0 <u>3</u> 00 В0 4 Α1 <u>6</u> 01 5 В1 13 Α2 <u>11</u> O2 12 B2 10 АЗ 8 O3 9 ВЗ

Figure 2. Logic Diagram

#### **PIN NAMES**

Pins	Function		
An, Bn	Data Inputs		
On	Outputs		

#### **TRUTH TABLE**

Inp	outs	Outputs
An	Bn	On
L	L	L
L	Н	L
Н	L	L
Н	Н	Н

H = High Voltage Level L = Low Voltage Level

For  $\ensuremath{I_{CC}}$  reasons, DO NOT FLOAT Inputs

#### **MAXIMUM RATINGS**

Symbol	Parameter	Value	Condition	Unit
V <sub>CC</sub>	DC Supply Voltage	-0.5 to +6.5		V
VI	DC Input Voltage	$-0.5 \le V_1 \le +6.5$		V
Vo	DC Output Voltage	$-0.5 \le V_{O} \le V_{CC} + 0.5$	Output in HIGH or LOW State (Note 1)	V
I <sub>IK</sub>	DC Input Diode Current	-50	V <sub>I</sub> < GND	mA
I <sub>OK</sub>	DC Output Diode Current	-50	V <sub>O</sub> < GND	mA
		+50	V <sub>O</sub> > V <sub>CC</sub>	mA
Io	DC Output Source/Sink Current	±50		mA
Icc	DC Supply Current Per Supply Pin	±100		mA
I <sub>GND</sub>	DC Ground Current Per Ground Pin	±100		mA
T <sub>STG</sub>	Storage Temperature Range	-65 to +150		°C
T <sub>L</sub>	Lead Temperature, 1 mm from Case for 10 Seconds	T <sub>L</sub> = 260		°C
TJ	Junction Temperature Under Bias	T <sub>J</sub> = 135		°C
$\theta_{JA}$	Thermal Resistance (Note 2)	SOIC = 85 TSSOP = 100		°C/W
MSL	Moisture Sensitivity		Level 1	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. I<sub>O</sub> absolute maximum rating must be observed.

2. Measured with minimum pad spacing on an FR4 board, using 10 mm-by-1 inch, 2 ounce copper trace no air flow.

#### **RECOMMENDED OPERATING CONDITIONS**

Symbol	Parameter	Min	Тур	Max	Units
V <sub>CC</sub>	Supply Voltage Operating Functional	1.65 1.2		3.6 3.6	V
VI	Input Voltage	0		5.5	V
Vo	Output Voltage HIGH or LOW State 3-State	0 0		V <sub>CC</sub> 5.5	V
I <sub>OH</sub>	$\begin{array}{l} \text{HIGH Level Output Current} \\ \text{$V_{CC} = 3.0 \ V - 3.6 \ V} \\ \text{$V_{CC} = 2.7 \ V - 3.0 \ V} \end{array}$			-24 -12	mA
I <sub>OL</sub>	LOW Level Output Current $V_{CC} = 3.0 \text{ V} - 3.6 \text{ V}$ $V_{CC} = 2.7 \text{ V} - 3.0 \text{ V}$			24 12	mA
T <sub>A</sub>	Operating Free–Air Temperature	-40		+125	°C
Δt/ΔV	Input Transition Rise or Fall Rate V <sub>CC</sub> = 1.65 V to 2.7 V V <sub>CC</sub> = 2.7 V to 3.6 V	0 0		20 10	ns/V

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

#### DC ELECTRICAL CHARACTERISTICS

			-4	0°C to +8	5°C	-40	°C to +12	5°C	
Symbol	Parameter	Conditions	Min	Typ (Note 3)	Max	Min	Typ (Note 3)	Max	Unit
VIH	HIGH-level input	V <sub>CC</sub> = 1.2 V	1.08	-	-	1.08	-	-	V
	voltage	V <sub>CC</sub> = 1.65 V to 1.95 V	0.65 x V <sub>CC</sub>	_	-	0.65 x V <sub>CC</sub>	_	_	
		V <sub>CC</sub> = 2.3 V to 2.7 V	1.7	-	-	1.7	-	_	
		$V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	2.0	-	_	2.0	-	-	
$V_{IL}$	LOW-level input	V <sub>CC</sub> = 1.2 V	_	-	0.12	-	-	0.12	V
	voltage	V <sub>CC</sub> = 1.65 V to 1.95 V	_	_	0.35 x V <sub>CC</sub>	-	_	0.35 x V <sub>CC</sub>	
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	_	-	0.7	_	-	0.7	
		V <sub>CC</sub> = 2.7 V to 3.6 V	_	-	0.8	-	-	8.0	
V <sub>OH</sub>	HIGH-level output	$V_I = V_{IH}$	or V <sub>IL</sub>						V
	voltage	$I_O = -100 \mu A;$ $V_{CC} = 1.65 \text{ V to } 3.6 \text{ V}$	V <sub>CC</sub> - 0.2	_	-	V <sub>CC</sub> - 0.3	_	-	
		$I_O = -4 \text{ mA}; V_{CC} = 1.65 \text{ V}$	1.2	-	-	1.05	-	-	
		$I_{O} = -8 \text{ mA}; V_{CC} = 2.3 \text{ V}$	1.8	-	-	1.65	-	-	
		$I_O = -12 \text{ mA}; V_{CC} = 2.7 \text{ V}$	2.2	-	-	2.05	-	-	
		$I_O = -18 \text{ mA}; V_{CC} = 3.0 \text{ V}$	2.4	-	-	2.25	-	-	
		$I_O = -24$ mA; $V_{CC} = 3.0$ V	2.2	-	-	2.0	-	-	
VOL	LOW-level output	$V_I = V_{IH}$	IH or V <sub>IL</sub>						V
	voltage	$I_O = 100 \mu A;$ $V_{CC} = 1.65 \text{ V to } 3.6 \text{ V}$	_	-	0.2	-	-	0.3	
		$I_O = 4 \text{ mA}; V_{CC} = 1.65 \text{ V}$	_	-	0.45	_	-	0.65	
		I <sub>O</sub> = 8 mA; V <sub>CC</sub> = 2.3 V	-	-	0.6	-	-	8.0	
		$I_O = 12 \text{ mA}; V_{CC} = 2.7 \text{ V}$	_	-	0.4	_	-	0.6	
		$I_O = -24 \text{ mA}; V_{CC} = 3.0 \text{ V}$	_	-	0.55	_	-	8.0	
I <sub>I</sub>	Input leakage current	$V_I = 5.5 V$ or GND $V_{CC} = 3.6 V$	_	±0.1	±5	_	±0.1	±20	μΑ
l <sub>OFF</sub>	Power–off leakage current	$V_1 \text{ or } V_0 = 5.5 \text{ V}; V_{CC} = 0.0 \text{ V}$	-	±0.1	±10	-	±0.1	±20	μΑ
I <sub>CC</sub>	Supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 3.6 \text{ V}$	_	0.1	10	-	0.1	40	μΑ
Δl <sub>CC</sub>	Additional supply current	per input pin; $V_{I} = V_{CC} - 0.6 \text{ V}; I_{O} = 0 \text{ A};$ $V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	-	5	500	_	5	5000	μΑ

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. All typical values are measured at  $T_A = 25^{\circ}C$  and  $V_{CC} = 3.3$  V, unless stated otherwise.

#### AC ELECTRICAL CHARACTERISTICS ( $t_R = t_F = 2.5 \text{ ns}$ )

			-40	-40°C to +85°C		-40°C to +125°C			
Symbol	Parameter	Conditions	Min	Typ <sup>1</sup>	Max	Min	Typ <sup>1</sup>	Max	Unit
t <sub>pd</sub>	Propagation Delay (Note 5)	V <sub>CC</sub> = 1.2 V	-	11.0	_	-	-	_	ns
		V <sub>CC</sub> = 1.65 V to 1.95 V	0.5	4.2	9.0	0.5	_	10.4	ns
		V <sub>CC</sub> = 2.3 V to 2.7 V	1.0	2.5	6.9	1.0	_	8.0	
		V <sub>CC</sub> = 2.7 V	1.5	2.5	4.8	1.5	-	5.6	
		V <sub>CC</sub> = 3.0 V to 3.6 V	1.0	2.3	4.1	1.0	-	4.8	
t <sub>sk(0)</sub>	Output Skew Time (Note 6)	$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	-	-	1.0	-	_	1.5	ns

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- 4. Typical values are measured at TA = 25°C and Vcc = 3.3 V, unless stated otherwise.
- 5. t<sub>pd</sub> is the same as t<sub>PLH</sub> and t<sub>PHL</sub>.
  6. Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH-to-LOW (t<sub>OSHL</sub>) or LOW-to-HIGH (t<sub>OSLH</sub>); parameter guaranteed by design.

#### **DYNAMIC SWITCHING CHARACTERISTICS**

			T <sub>A</sub> = +25°C			
Symbol	Characteristic	Condition	Min	Тур	Max	Unit
V <sub>OLP</sub>	Dynamic LOW Peak Voltage (Note 7)	$\begin{aligned} &V_{CC} = 3.3 \text{ V, } C_L = 50 \text{ pF, } V_{IH} = 3.3 \text{ V, } V_{IL} = 0 \text{ V} \\ &V_{CC} = 2.5 \text{ V, } C_L = 30 \text{ pF, } V_{IH} = 2.5 \text{ V, } V_{IL} = 0 \text{ V} \end{aligned}$		0.8 0.6		V
V <sub>OLV</sub>	Dynamic LOW Valley Voltage (Note 7)	$V_{CC} = 3.3 \text{ V}, C_L = 50 \text{ pF}, V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$ $V_{CC} = 2.5 \text{ V}, C_L = 30 \text{ pF}, V_{IH} = 2.5 \text{ V}, V_{IL} = 0 \text{ V}$		-0.8 -0.6		V

<sup>7.</sup> Number of outputs defined as "n". Measured with "n-1" outputs switching from HIGH-to-LOW or LOW-to-HIGH. The remaining output is measured in the LOW state.

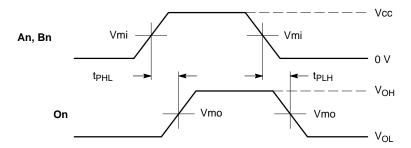
#### **CAPACITIVE CHARACTERISTICS**

Symbol	Parameter	Condition	Typical	Unit
CIN	Input Capacitance	$V_{CC}$ = 3.3 V, $V_{I}$ = 0 V or $V_{CC}$	4.0	pF
Соит	Output Capacitance	$V_{CC}$ = 3.3 V, $V_{I}$ = 0 V or $V_{CC}$	5.0	pF
$C_{PD}$	Power Dissipation Capacitance	Per input; V <sub>I</sub> = GND or V <sub>CC</sub>		
	(Note 8)	V <sub>CC</sub> = 1.65 V to 1.95 V	4.4	
		V <sub>CC</sub> = 2.3 V to 2.7 V	7.7	
		V <sub>CC</sub> = 3.0 V to 3.6 V	10.5	

<sup>8.</sup>  $C_{PD}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu W$ ).

 $P_D = C_{PD} \times V_{CC}^2 \times \text{fi} \times N + \Sigma (C_L \times V_{CC}^2 \times \text{fo})$  where: fi = input frequency in MHz; fo = output frequency in MHz  $C_L = \text{output load capacitance in pF } V_{CC} = \text{supply voltage in Volts}$ 

N = number of outputs switching  $\Sigma(C_L \times V_{CC}^2 \times fo)$  = sum of the outputs.

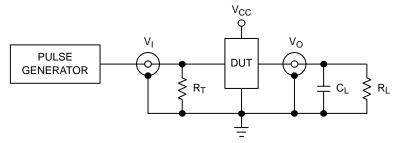


**WAVEFORM 1 – PROPAGATION DELAYS** 

 $t_R = t_F = 2.5 \text{ ns}$ , 10% to 90%; f = 1 MHz;  $t_W = 500 \text{ ns}$ 

	Vcc					
Symbol	3.3 V ± 0.3 V	2.7 V	V <sub>CC</sub> < 2.7 V			
Vmi	1.5 V	1.5 V	Vcc/2			
Vmo	1.5 V	1.5 V	Vcc/2			

Figure 3. AC Waveforms



 $\rm C_L$  includes jig and probe capacitance  $\rm R_T = \rm Z_{OUT}$  of pulse generator (typically 50  $\Omega)$ 

Supply Voltage	Input		Lo	ad
V <sub>CC</sub> (V)	VI	t <sub>r</sub> , t <sub>f</sub>	CL	R <sub>L</sub>
1.2	V <sub>CC</sub>	≤ 2 ns	30 pF	1 kΩ
1.65 – 1.95	V <sub>CC</sub>	≤ 2 ns	30 pF	1 kΩ
2.3 – 2.7	V <sub>CC</sub>	≤ 2 ns	30 pF	500 Ω
2.7	2.7 V	≤ 2.5 ns	50 pF	500 Ω
3 – 3.6	2.7 V	≤ 2.5 ns	50 pF	500 Ω

Figure 4. Test Circuit

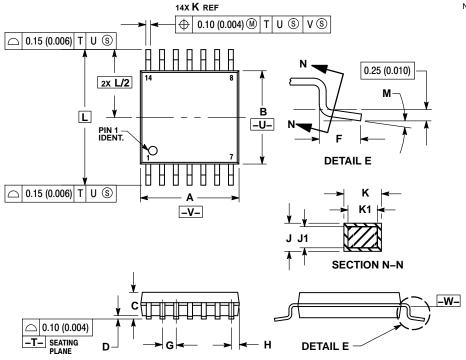
#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
74LVC08ADR2G	SOIC-14 (Pb-Free)	2500 / Tape & Reel
74LVC08ADTR2G	TSSOP-14 (Pb-Free)	2500 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS

#### TSSOP-14 CASE 948G **ISSUE B**



- NOTES:
  1. DIMENSIONING AND TOLERANCING PER

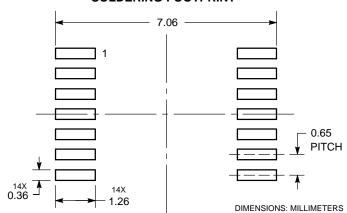
  - 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
    2. CONTROLLING DIMENSION: MILLIMETER.
    3. DIMENSION A DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH OR GATE BURRS SHALL NOT EXCEED 0.15 (0.006) PER SIDE.
    4. DIMENSION B DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 (0.010) PER SIDE.
    5. DIMENSION K DOES NOT INCLUDE DAMBAR PROTRUSION. SHALL DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE K DIMENSION AT MAXIMUM MATERIAL CONDITION.
  - CONDITION.

    5. TERMINAL NUMBERS ARE SHOWN FOR
  - REFERENCE ONLY.

    7. DIMENSION A AND B ARE TO BE DETERMINED AT DATUM PLANE –W–.

	MILLIN	IETERS	INC	HES
DIM	MIN	MAX	MIN	MAX
Α	4.90	5.10	0.193	0.200
В	4.30	4.50	0.169	0.177
C		1.20		0.047
D	0.05	0.15	0.002	0.006
F	0.50	0.75	0.020	0.030
G	0.65	BSC	0.026 BSC	
Н	0.50	0.60	0.020	0.024
L	0.09	0.20	0.004	0.008
J1	0.09	0.16	0.004	0.006
Κ	0.19	0.30	0.007	0.012
K1	0.19	0.25	0.007	0.010
Г	6.40 BSC		0.252	BSC
М	0 °	8 °	0°	8 °

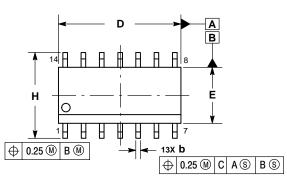
#### **SOLDERING FOOTPRINT\***



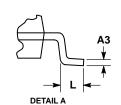
\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

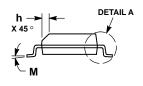
#### PACKAGE DIMENSIONS

#### SOIC-14 NB CASE 751A-03 ISSUE K



е





#### NOTES

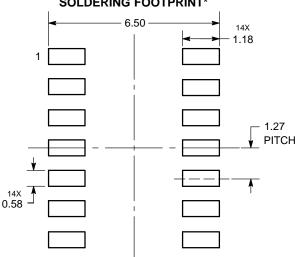
- 1. DIMENSIONING AND TOLERANCING PER
- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
   CONTROLLING DIMENSION: MILLIMETERS.
   DIMENSION b DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE PROTRUSION SHALL BE 0.13 TOTAL IN EXCESS OF AT MAXIMUM MATERIAL CONDITION.
  4. DIMENSIONS D AND E DO NOT INCLUDE
- MOLD PROTRUSIONS.

  5. MAXIMUM MOLD PROTRUSION 0.15 PER

	MILLIMETERS		INCHES	
DIM	MIN	MAX	MIN	MAX
Α	1.35	1.75	0.054	0.068
A1	0.10	0.25	0.004	0.010
A3	0.19	0.25	0.008	0.010
b	0.35	0.49	0.014	0.019
D	8.55	8.75	0.337	0.344
Е	3.80	4.00	0.150	0.157
е	1.27 BSC		0.050 BSC	
Н	5.80	6.20	0.228	0.244
h	0.25	0.50	0.010	0.019
L	0.40	1.25	0.016	0.049
М	0°	7°	0°	7°

#### SOLDERING FOOTPRINT'

C SEATING PLANE



**DIMENSIONS: MILLIMETERS** 

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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 74LS38
 74LVC32ADTR2G
 MC74HCT20ADTR2G
 NLV17SZ00DFT2G
 NLV17SZ02DFT2G
 NLV74HC02ADR2G

 74HC32S14-13
 74LS133
 74LVC1G32Z-7
 M38510/30402BDA
 74LVC1G86Z-7
 74LVC2G08RA3-7
 NLV74HC08ADTR2G

 NLV74HC14ADR2G
 NLV74HC20ADR2G
 NLX2G86MUTCG
 5962-8973601DA
 74LVC2G02HD4-7
 NLU1G00AMUTCG

 74LVC2G32RA3-7
 74LVC2G00HD4-7
 NL17SG02P5T5G
 74LVC2G00HK3-7
 74LVC2G86HK3-7
 NLX1G99DMUTWG

 NLV7HC1G00DFT2G
 NLV1G08DFT2G
 NLV7SZ57DFT2G
 NLV74VHC04DTR2G
 NLV27WZ86USG
 NLV27WZ00USG

 NLU1G86CMUTCG
 NLU1G08CMUTCG
 NL17SZ32P5T5G
 NL17SZ00P5T5G
 NL17SH02P5T5G
 74AUP2G00RA3-7

 NLV74HC02ADTR2G
 NLX1G332CMUTCG
 NL17SG86P5T5G
 NL17SZ05P5T5G
 NLV74VHC00DTR2G